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	Application/Control No.	Applicant(s)/Patent under		
		Reexamination		
	10/789,210	PLONA ET AL.		
	Examiner	Art Unit		
•	Scott A. Hughes	3663		

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SEARCH NOT	'ES	
(INCLUDING SEARCH)
	DATE	EXMR
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GeoRef: slowness projection log, STC versus depth, dispersion curve versus	8/17/2007	SAH
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